TEST REPORT

APPLICANT	:	Great Talent Technology Limited
PRODUCT NAME	:	Smart Phone
MODEL NAME	:	ACK2326
BRAND NAME	:	ANS
FCC ID	:	2ALZM-ACK2326
STANDARD(S)	:	47 CFR Part 15 Subpart B
RECEIPT DATE	:	2022-04-01
TEST DATE	:	2022-04-13 to 2022-04-15
ISSUE DATE	:	2022-05-25

Edited by: Yu Xiaolin

Yu Xiaolin(Rapporteur)

Approved by: Xiao Xiong

Xiao Xiong(Supervisor)

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MORLAB

Shenzhen Morlab Communications Technology Co., Ltd.
FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road,
Block67, BaoAn District, ShenZhen ,GuangDong Province, P. R. China

Tel: 86-755-36698555 Fax: 86-755-36698525
Http://www.morlab.cn E-mail: service@morlab.cn

DIRECTORY

1. Technical Information 3
1.1. Applicant and Manufacturer Information 3
1.2. Equipment Under Test (EUT) Description 3
2. Test Results 5
2.1. Applied Reference Documents 5
2.2. EUT Setup and Operating Conditions 6
3. 47 CFR Part 15B Requirements 8
3.1. Conducted Emission 8
3.2. Radiated Emission 12
Annex A Test Uncertainty 19
Annex B Testing Laboratory Information 20

Change History		
Version	**Date**	**Reason for Change**
1.0	2022-05-25	First edition

1. Technical Information

Note: Provide by applicant

1.1. Applicant and Manufacturer Information

Applicant:	Great Talent Technology Limited
Applicant Address:	35F, HBC HuiLong Center Building-II Minzhi Street, Longhua, Shenzhen, P. R. China 518110
Manufacturer:	Great Talent Technology Limited
Manufacturer Address:	35F, HBC HuiLong Center Building-II Minzhi Street, Longhua, Shenzhen, P. R. China 518110

1.2. Equipment Under Test (EUT) Description

Product Name:	Smart Phone
EUT No.:	9#
Hardware Version:	Q6002_V1.0
Software Version:	ACK2326V1.0.0B001
Tx Frequency:	GSM850: 824 MHz ~ 849 MHz GSM1900: 1850 MHz ~ 1910 MHz WCDMA Band II: 1850 MHz ~ 1910 MHz WCDMA Band IV: 1710 MHz ~ 1755 MHz WCDMA Band V: 824 MHz ~ 849 MHz LTE Band 2: 1850 MHz ~ 1910 MHz LTE Band 4: 1710 MHz ~ 1755 MHz LTE Band 5: 824 MHz ~ 849 MHz LTE Band 12: 699 MHz ~ 716 MHz LTE Band 25: 1850 MHz ~ 1915 MHz LTE Band 26: 814 MHz ~ 849 MHz LTE Band 41: 2496 MHz ~ 2690 MHz LTE Band 66: 1710 MHz ~ 1780 MHz LTE Band 71: 663 MHz ~ 698 MHz Bluetooth: 2402 MHz ~ 2480 MHz 802.11b/g/n: 2412 MHz ~ 2462 MHz 802.11a/ac/n: 5180 MHz ~ 5240 MHz; 5745 MHz ~ 5825 MHz

Rx Frequency:	GSM850: 869 MHz ~ 894 MHz GSM1900: 1930 MHz ~ 1990 MHz WCDMA Band II: 1930 MHz ~ 1990 MHz WCDMA Band IV: 2110 MHz ~ 2155 MHz WCDMA Band V: 869 MHz ~ 894 MHz LTE Band 2: 1930 MHz ~ 1990 MHz LTE Band 4: 2110 MHz ~ 2155 MHz LTE Band 5: 869 MHz ~ 894 MHz LTE Band 12: 729 MHz ~ 746 MHz LTE Band 25: 1930 MHz ~ 1995 MHz LTE Band 26: 859 MHz ~894 MHz LTE Band 41: 2496 MHz ~ 2690 MHz LTE Band 66: 2110 MHz ~ 2200 MHz LTE Band 71: 617 MHz ~ 652 MHz Bluetooth: 2402 MHz ~ 2480 MHz 802.11b/g/n: 2412 MHz ~ 2462 MHz 802.11a/ac/n: 5180 MHz ~ 5240 MHz; 5745 MHz ~ 5825 MHz GPS/GLONASS/BDS/Galileo :1559MHz ~ 1610MHz	
Ancillary Equipment:	**AC Adapter**	
	Brand Name:	N/A
	Model No.:	TPA-46050200UU
	Serial No.:	(N/A, marked #1 by test site)
	Rated Input:	100-240V~ 50/60Hz, 0.3A
	Rated Output:	5.0V⎓2000mA
	Manufacturer:	Shenzhen Tianyin Electronics Co., Ltd.
	Battery	
	Brand Name:	N/A
	Model No.:	BTE-3005
	Serial No.:	(N/A, marked #1 by test site)
	Capacity:	3000mAh
	Rated Voltage:	3.8V
	Charge Limit:	4.35V
	Manufacturer:	Phenix New Energy (Hui Zhou) Co., Ltd.

Note:

1. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.

2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Test Engineer	Result	Method Determination Remark
1	15.107	Conducted Emission	2022.04.15	Wu Zhaoling	PASS	No deviation
2	15.109	Radiated Emission	2022.04.13	Li Hanbin	PASS	No deviation

Note 1: Additions to, deviation, or exclusions from the method shall be judged in the “method determination" column of add, deviate or exclude from the specific method shall be explained in the "Remark" of the above table.

Note 2: When the test result is a critical value, we will use the measurement uncertainty give the judgment result based on the 95% confidence intervals.

2.2. EUT Setup and Operating Conditions

Note: All of the following test modes are tested in all the test items.

Test Item	
Mode 1 :	GSM850 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 2 :	GSM1900 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 3 :	WCDMA Band II Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 4 :	WCDMA Band IV Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 5 :	WCDMA Band V Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 6 :	LTE Band 2 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 7 :	LTE Band 4 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 8 :	LTE Band 5 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 9 :	LTE Band 12 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 10 :	LTE Band 25 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 11 :	LTE Band 26 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 12 :	LTE Band 41 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 13 :	LTE Band 66 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 14 :	LTE Band 71 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 15 :	GSM850 Idle + Bluetooth Idle + 5.8GHz SRD + Adapter + Battery + USB Cable + Earphone + SIM Card
Mode 16 :	LTE Band 4 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card + GPS Rx
Mode 17 :	LTE Band 5 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card + GLONASS Rx
Mode 18 :	LTE Band 26 Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card + Galileo Rx
Mode 19 :	LTE Band 71 Idle + Bluetooth Idle + 5G WLAN Idle + Adapter + Battery + USB Cable

	+ Earphone + SIM Card + BDS Rx
Mode 20 :	**WCDMA Band II Idle + Bluetooth Idle + 2.4G WLAN Idle + Adapter + Battery + USB Cable + Earphone + SIM Card + Rear Camera + Recording Mode**
Mode 21 :	**LTE Band 2 Idle + Bluetooth Idle + 5G WLAN Idle + Battery + USB Cable + Earphone + SIM Card + PC + PC Adapter + Data Transfer Mode**
Remark: The above test mode in boldface (Mode 20) was the worst case of conducted emission test, only the test data of these modes were reported. The above test mode in boldface (Mode 21) was the worst case of radiated emission test, only the test data of these modes were reported.	

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

3. 47 CFR Part 15B Requirements

3.1. Conducted Emission

3.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50μH/50Ω line impedance stabilization network (LISN).

Frequency Range (MHz)	Conducted Limit (dBμV)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

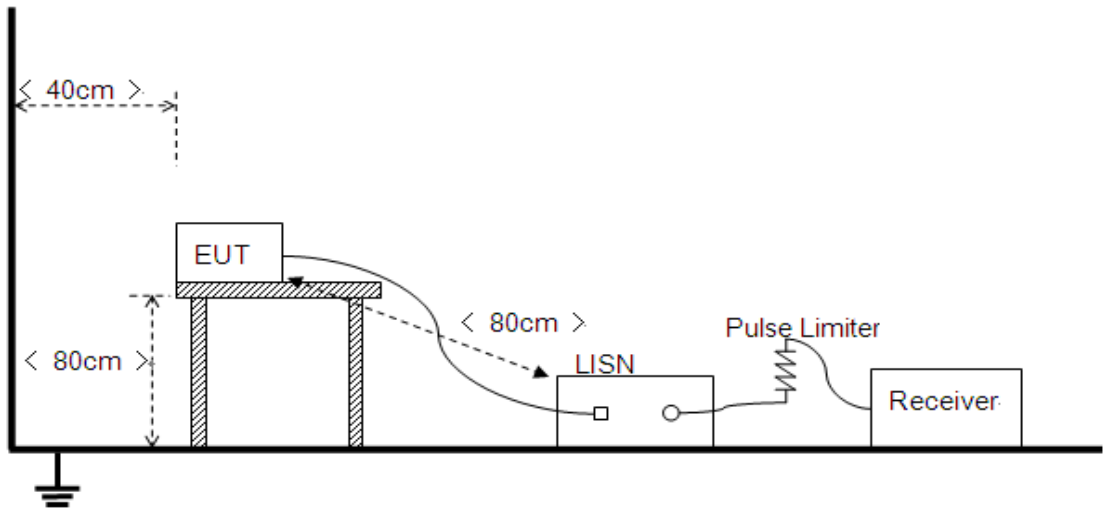
a) The limit subjects to the Class B digital device.

b) The lower limit shall apply at the band edges.

c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2. Test Setup

Please refer to Annex A for the photographs of the Test Configuration.



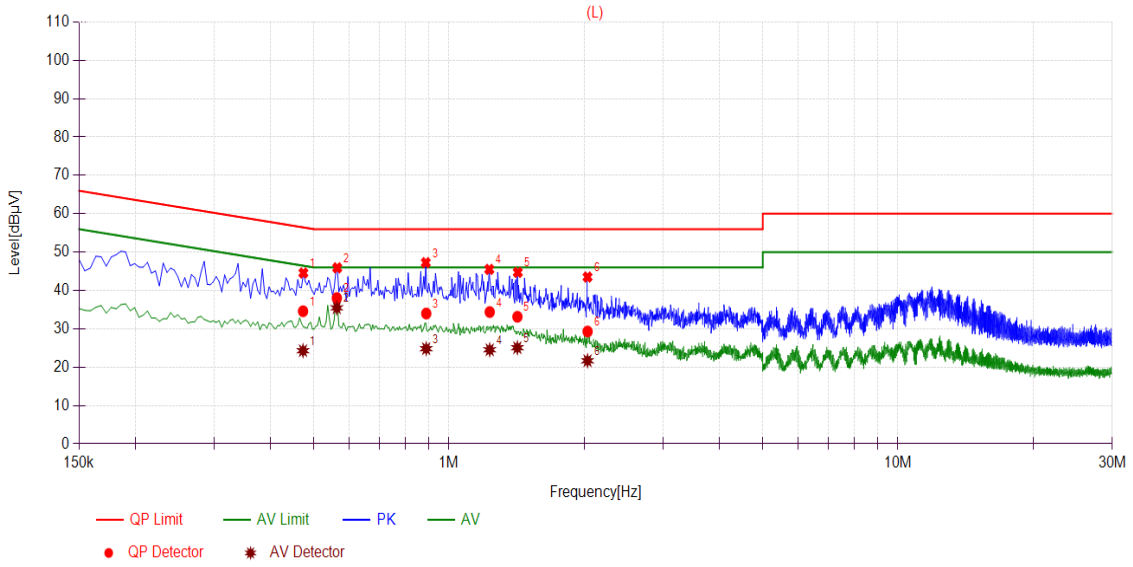
The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

The power strip or extension cord has been investigated to make sure that the LISN integrity inma intained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

3.1.3. Test Result

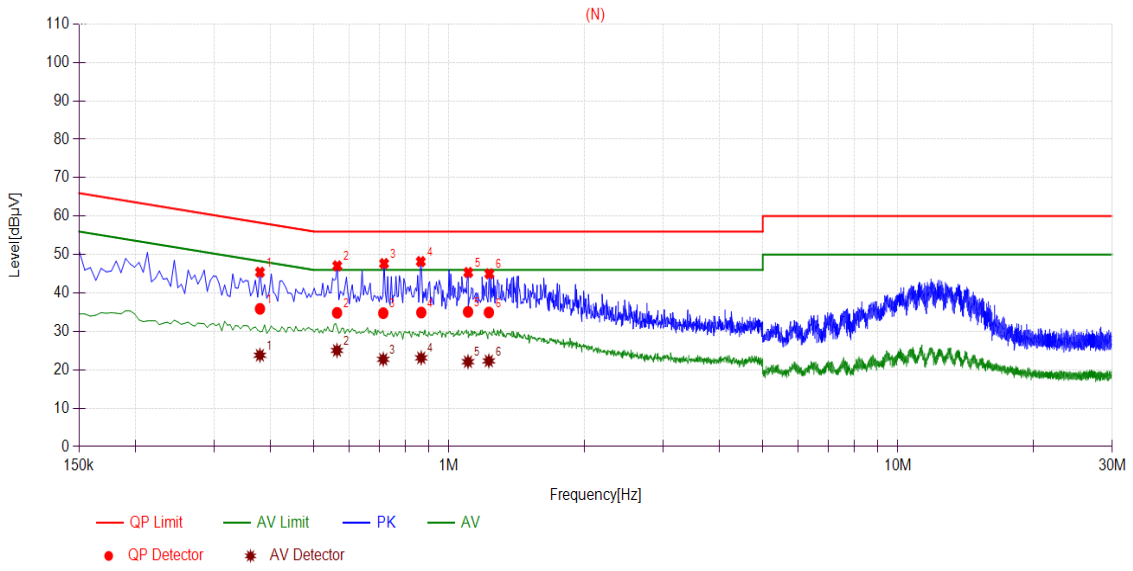
Set RBW=9 kHz, VBW=30 kHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

A. Test Plot and Suspicious Points:



(Plot A:L Phase)

NO.	Fre. (MHz)	Emission Level (dBµV)		Limit (dBµV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.4731	34.60	24.29	56.46	46.46	Line	PASS
2	0.5626	38.04	35.47	56.00	46.00		PASS
3	0.8898	34.00	24.82	56.00	46.00		PASS
4	1.2324	34.38	24.54	56.00	46.00		PASS
5	1.4201	33.14	25.07	56.00	46.00		PASS
6	2.0354	29.30	21.68	56.00	46.00		PASS



(Plot B: N Phase)

NO.	Fre. (MHz)	Emission Level (dBµV)		Limit (dBµV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.3793	35.88	23.80	58.29	48.29	Neutral	PASS
2	0.5632	34.83	25.04	56.00	46.00		PASS
3	0.7139	34.75	22.74	56.00	46.00		PASS
4	0.8676	34.91	23.12	56.00	46.00		PASS
5	1.1026	35.10	22.11	56.00	46.00		PASS
6	1.2268	34.93	22.32	56.00	46.00		PASS

3.2. Radiated Emission

3.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency Range (MHz)	Field Strength Limitation at 3m Measurement Dist	
	(μV/m)	(dBμV/m)
30.0 - 88.0	100	20log 100
88.0 - 216.0	150	20log 150
216.0 - 960.0	200	20log 200
Above 960.0	500	20log 500

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

1) The tighter limit shall apply at the boundary between two frequency range.
2) Limitation expressed in dBμV/m is calculated by 20log Emission Level(μV/m).

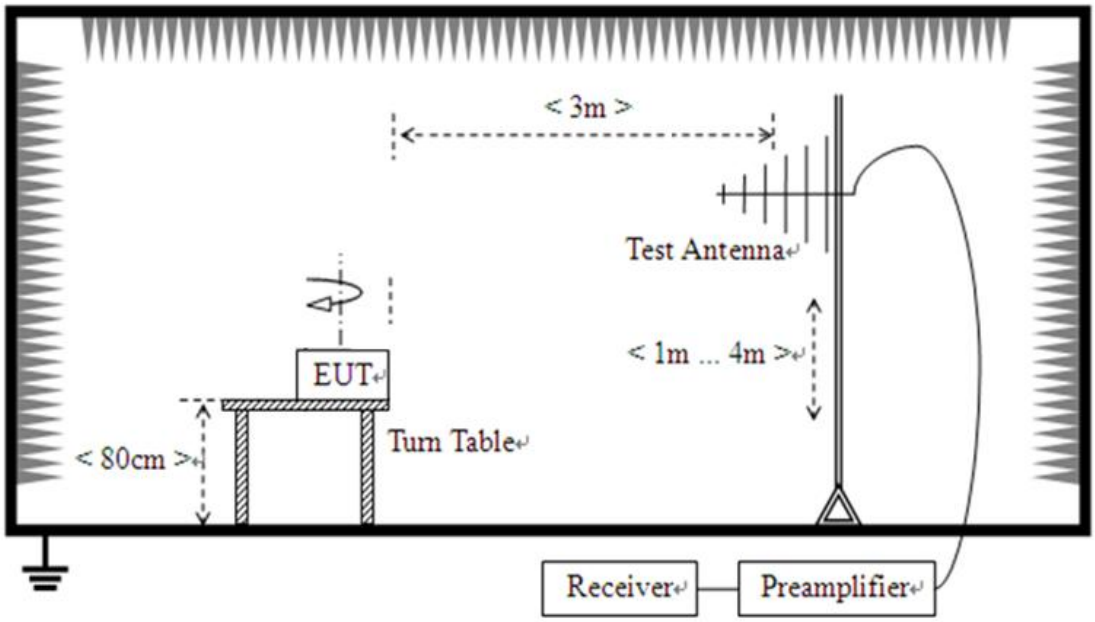
3.2.2. Frequency Range of Measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:

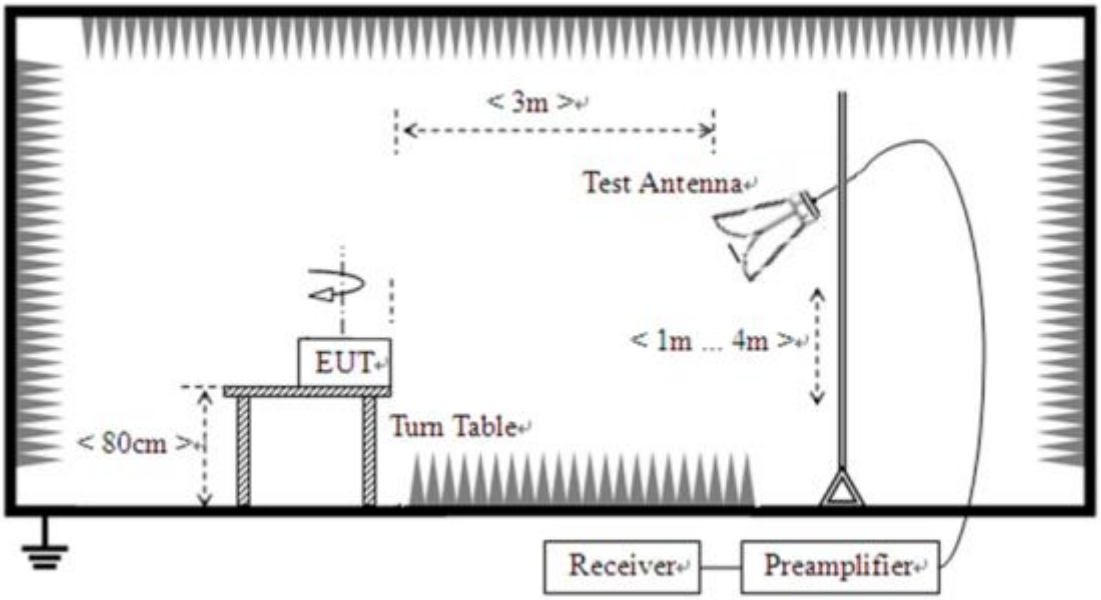
Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30.
1.705–108	1000.
108–500	2000.
500–1000	5000.
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.

3.2.3. Test Setup

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz)are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested. For measurements above 1 GHz, keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response.

For measurements below 1GHz the resolution bandwidth is set to 120 kHz for peak detection measurements or 120 kHz for quasi-peak detection measurements. Peak detection is used unless otherwise noted as quasi-peak.

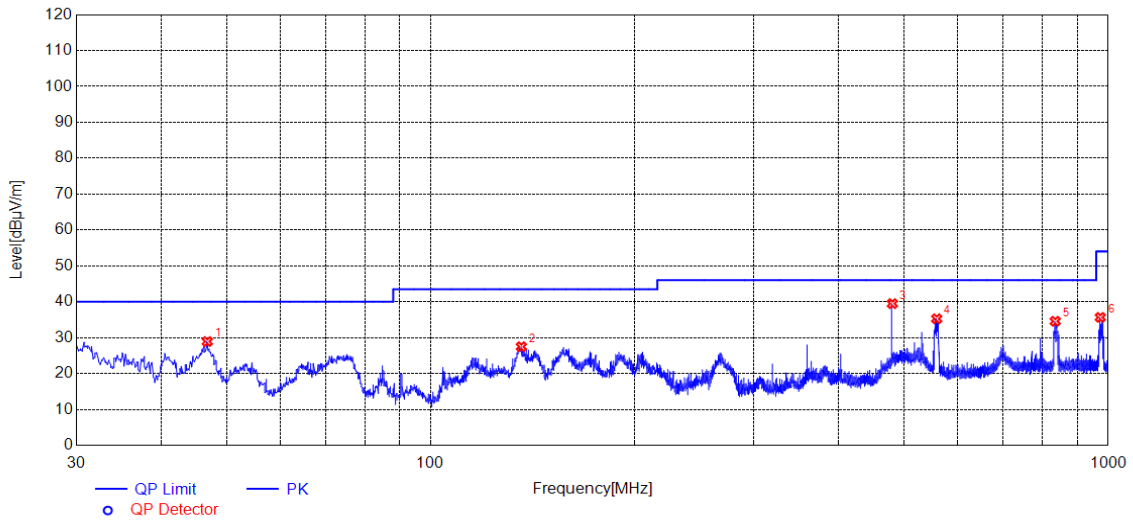
For measurements above 1GHz the resolution bandwidth is set to 1MHz, the video bandwidth is set to 3MHz for peak measurements and as applicable for average measurements.

3.2.4. Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

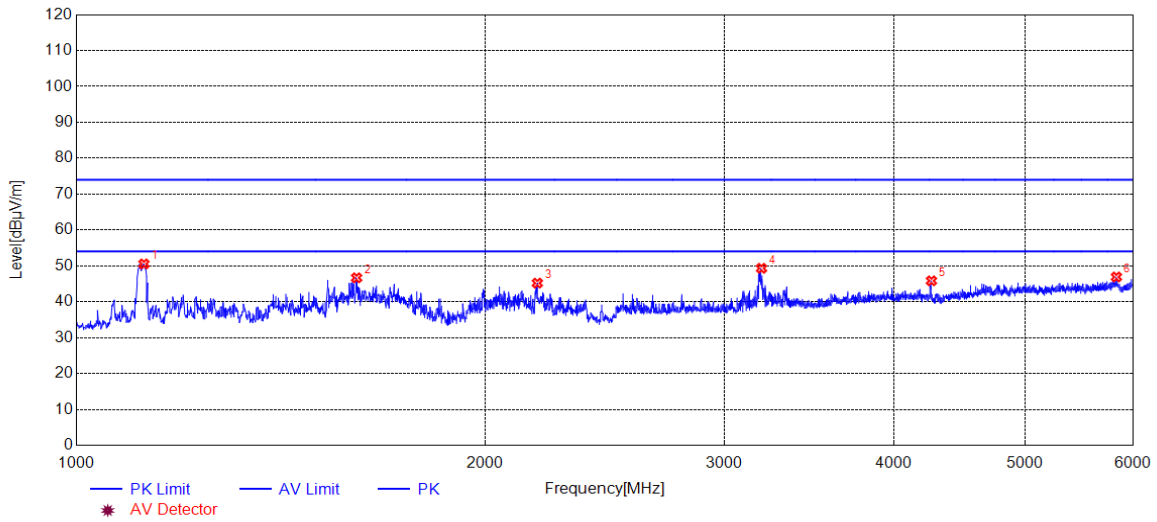
The amplitude of emissions which (6GHz-30GHz) are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.



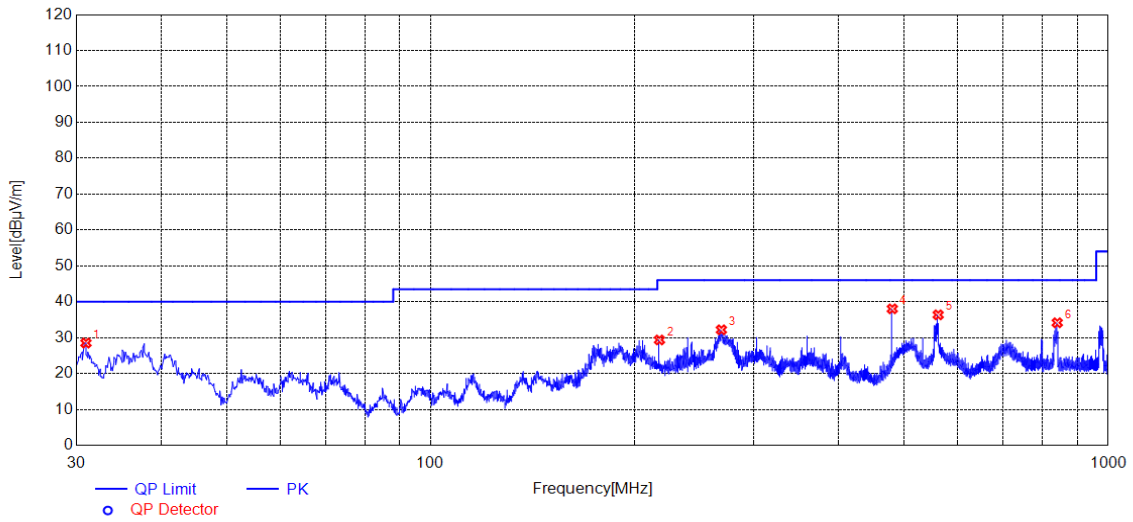
(Plot A: ANT-Vertical,30MHz - 1GHz)

No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	46.7827	28.92	N.A	N.A	N.A	40.00	N.A	V	PASS
2	136.0316	27.49	N.A	N.A	N.A	43.50	N.A	V	PASS
3	480.0280	39.48	N.A	N.A	N.A	46.00	N.A	V	PASS
4	558.1208	35.27	N.A	N.A	N.A	46.00	N.A	V	PASS
5	835.0835	34.57	N.A	N.A	N.A	46.00	N.A	V	PASS
6	973.4193	35.65	N.A	N.A	N.A	54.00	N.A	V	PASS



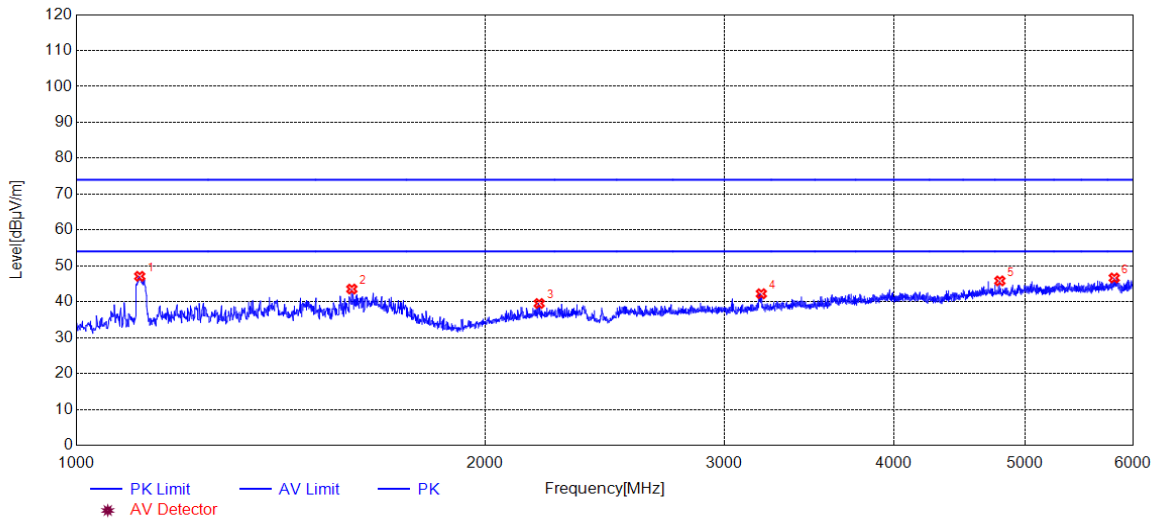
(Plot B: ANT-Vertical,1GHz - 6GHz)

No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	1121.0242	50.54	N.A	N.A	74.00	N.A	54.00	V	PASS
2	1608.1216	46.67	N.A	N.A	74.00	N.A	54.00	V	PASS
3	2185.2370	45.20	N.A	N.A	74.00	N.A	54.00	V	PASS
4	3196.4393	49.32	N.A	N.A	74.00	N.A	54.00	V	PASS
5	4264.6529	45.84	N.A	N.A	74.00	N.A	54.00	V	PASS
6	5836.9674	46.91	N.A	N.A	74.00	N.A	54.00	V	PASS



(Plot C:ANT- Horizontal, 30MHz - 1GHz)

No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	30.9701	28.50	N.A	N.A	N.A	40.00	N.A	H	PASS
2	217.5198	29.36	N.A	N.A	N.A	46.00	N.A	H	PASS
3	268.4498	32.19	N.A	N.A	N.A	46.00	N.A	H	PASS
4	480.0280	38.03	N.A	N.A	N.A	46.00	N.A	H	PASS
5	560.9341	36.36	N.A	N.A	N.A	46.00	N.A	H	PASS
6	840.8071	34.15	N.A	N.A	N.A	46.00	N.A	H	PASS



(Plot D:ANT- Horizontal, 1GHz - 6GHz)

No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	1113.0226	47.09	N.A	N.A	74.00	N.A	54.00	H	PASS
2	1595.1190	43.54	N.A	N.A	74.00	N.A	54.00	H	PASS
3	2192.2384	39.53	N.A	N.A	74.00	N.A	54.00	H	PASS
4	3195.4391	42.24	N.A	N.A	74.00	N.A	54.00	H	PASS
5	4789.7580	45.82	N.A	N.A	74.00	N.A	54.00	H	PASS
6	5815.9632	46.63	N.A	N.A	74.00	N.A	54.00	H	PASS

Annex A Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission Measurement

Measuring Uncertainty for a Level of Confidence of 95%(U=2Uc(y))	9kHz-150kHz	±3.3dB
	150kHz-30MHz	±2.8dB

Uncertainty of Radiated Emission Measurement

Measuring Uncertainty for a Level of Confidence of 95%(U=2Uc(y))	30MHz-200MHz	±5.06dB
	200MHz-1000MHz	±5.04dB
	1GHz-6GHz	±5.18dB
	6GHz-18GHz	±5.48dB

Annex B Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Laboratory Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Laboratory Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory:	The FCC designation number is CN1192. Test firm registration number is 226174. (Shenzhen Morlab Communications Technology Co., Ltd.)

4. Test Software Utilized

Model	Version Number	Producer
TS+ -[JS32-RE]	Version 2.5.0.6	Tonscend
TS+ -[JS32-CE]	Version 2.5.0.0	Tonscend

5. Test Equipments Utilized

Description	Model	Serial No.	Manufacturer	Cal. Date	Due. Date
Bi-Log Antenna	VULB 9163	9163-519	SCHWARZBECK	2019/5/24	2022/5/23
Horn Antenna	BBHA 9120D	01774	SCHWARZBECK	2019/7/26	2022/7/25
Horn Antenna	BBHA 9170	BBHA 9170#773	SCHWARZBECK	2019/7/26	2022/7/25
Receiver	N9038A	MY56400093	KEYSIGHT	2022/3/3	2023/3/8
Receiver	N9038A	MY54130016	Agilent	2021/7/16	2022/7/15
6db Attenuator	BW-N6W5+	E191001	Mini-circuits	2021/10/18	2022/10/17
Preamplifier	S020180L3203	61171/61172	LUCIX CORP.	2021/7/16	2022/7/15
Preamplifier	S10M100L3802	46732	LUCIX CORP.	2021/7/16	2022/7/15
Preamplifier	S150300L3202	71136	LUCIX CORP.	2021/7/16	2022/7/15
Receiver	ESPI	101052	R&S	2021/7/16	2022/7/15
LISN	NSLK 8127	8127449	Schwarzbeck	2022/3/3	2023/3/8
10dB Pulse Limiter	VTSD 9561-F	VTSD 9561 F-B #206	SCHWARZBECK	2021/7/24	2022/7/23

5. Ancillary Equipment Utilized

Description	Manufacturer	Model	Serial No.
PC	DELL	P144G	20210357
PC Adapter	DELL	HA65NM190	NA
Earphone	VIVO	NA	NA

END OF REPORT